TOSHIBA Power MOS FET Module Silicon N Channel MOS Type (Four L<sup>2</sup>-π-MOSV in One)

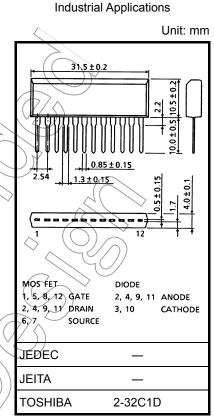
# MP4410

High Power, High Speed Switching Applications Hammer Drive, Pulse Motor Drive and Inductive Load Switching

- 4-V gate drivability
- Small package by full molding (SIP 12 pin)
- High drain power dissipation (4-device operation) :  $P_T = 28 W (T_c = 25^{\circ}C)$
- Low drain-source ON resistance:  $R_{DS}$  (ON) = 0.12  $\Omega$  (typ.)
- Low leakage current:  $I_{GSS} = \pm 10 \ \mu A \ (max) \ (V_{GS} = \pm 16 \ V)$  $I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 60 \ V)$
- Enhancement-mode:  $V_{th} = 0.8$  to 2.0 V (I<sub>D</sub> = 1 mA)

#### Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Drain-source voltage	V <sub>DSS</sub> <	60	X
Gate-source voltage	VGSS	±20	< V
Drain current	ID	)) 5	A
Peak drain current		20	A
Drain power dissipation (1-device operation)	PD	2.2	W
Drain power dissipation $Ta = 25^{\circ}C$ (4-device operation) $Tc = 25^{\circ}C$	Рт	4.4	⇒`w
Channel temperature	∠ T <sub>ch</sub>	150	°C
Storage temperature range	Tstg	-55 to 150	°C

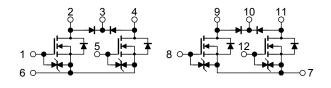


Weight: 3.9 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

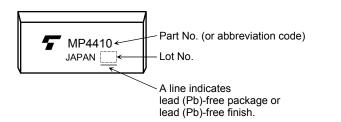
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Array Configuration**



# **TOSHIBA**

#### Marking



#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance of channel to ambient	ΣR <sub>th (ch-a)</sub>	28.4	°C/W
(4-device operation, Ta = 25°C)	( )		
Thermal resistance of channel to case		4.46	°C/W
(4-device operation, Tc = 25°C)	ΣR <sub>th (ch-c)</sub>	4.40	C/W
Maximum lead temperature for soldering purposes	ΤL	260	°C
(3.2 mm from case for 10 s)	_	<	$\langle \bigcirc \rangle$

This transistor is an electrostatic-sensitive device. Please handle with caution

## Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage current		GSS	$V_{GS} = \pm 16 V, V_{DS} = 0 V$			±10	μA	
Drain cut-off curre	nt	IDSS	$V_{DS} = 60 V, V_{GS} = 0 V$	-	-	100	μA	
Drain-source brea	kdown voltage	V (BR) DSS	$I_{\rm D} = 10 \text{ mA}, \forall_{\rm GS} = 0 \text{ V}$	60	-	_	V	
Gate threshold vo	Itage	∕ V <sub>th</sub>	$V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA}$	0.8	_	2.0	V	
Forward transfer a	admittance	Y <sub>fs</sub>   <	$V_{\rm QS} = 10 V, I_{\rm D} = 2.5 \rm A$	3.0	5.0	_	S	
Drain-source ON resistance			$I_D$ = 2.5 A, $V_{GS}$ = 4 V	-	0.21	0.31	0	
Drain-source ON		RDS (ON)	I <sub>D</sub> = 2.5 A, V <sub>GS</sub> = 10 V	-	0.12	0.16	Ω	
Input capacitance		C <sub>iss</sub>		-	370	_	pF	
Reverse transfer capacitance		Crss	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	60	_	pF	
Output capacitance	æ	Coss		_	180	_	pF	
Switching time Fall time	Rise time	tr	$I_{D} = 2.5 \text{ A}$ $I_{D} = 2.5 \text{ A}$ $V_{IN}$ $V_{IN}$ $V_{IN}$ $V_{IN}$ $V_{IN}$ $V_{IN}$ $V_{IN}$ $V_{OU} = 0$ $V_{OUT}$ $V_{OU} = 0$ $V_{OUT}$ $V_{OU} = 0$ $V_{OU} = 0$	_	18	_		
	Turn-on time	ton		_	25	_	ns	
	Fall time	t <sub>f</sub>		_	15	_	115	
	Turn-off time	t <sub>off</sub>	$V_{IN}$ : t <sub>r</sub> , t <sub>f</sub> < 5 ns, dutys cycle ≤ 1%	_	170	_		
Total gate charge       (gate-source plus gate-drain)         Gate-source charge       Gate-drain ("miller") charge		Qg	-	_	12	—	nC	
		Q <sub>gs</sub>	I <sub>D</sub> = 5 A, V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 48 V	_	8	_	nC	
		Q <sub>gd</sub>		_	4	_	nC	

**TOSHIBA** 

## Source-Drain Diode Rating and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	I <sub>DR</sub>	—	_	_	5	А
Peak drain reverse current	I <sub>DRP</sub>	—	_	_	20	А
Diode forward voltage	V <sub>DSF</sub>	I <sub>DR</sub> = 5 A, V <sub>GS</sub> = 0 V	X		-1.7	V

# Flyback-Diode Rating and Characteristics (Ta = 25°C)

Symbol	т	est Condition	Min	Тур.	Max	Unit
I <sub>FM</sub>		-		—	5	А
I <sub>R</sub>	V <sub>R</sub> = 120 V		_	—	0.4	μA
VR	I <sub>R</sub> = 100 μA		120	$\square$	1	V
VF	I <sub>F</sub> = 1 A	$\langle \langle \rangle \rangle$		44	1.8	V
	I <sub>FM</sub> I <sub>R</sub> V <sub>R</sub>	I <sub>FM</sub> I <sub>R</sub> V <sub>R</sub> = 120 V V <sub>R</sub> I <sub>R</sub> = 100 μA	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $

#### **RESTRICTIONS ON PRODUCT USE**

Handbook" etc.

The information contained herein is subject to change without notice.

20070701-EN

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
   In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in his document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third parties.
- Please contact your sales representative for product-by-product details in this document regarding RoHS compatibility. Please use these products in this document in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses occurring as a result of noncompliance with applicable laws and regulations.